

<b>Notice of References Cited</b>	Application/Control No. 10/829,444	Applicant(s)/Patent Under Reexamination TANIMOTO ET AL.	
	Examiner Richard K. Lee	Art Unit 2832	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,199,317	04-2007	Ieda et al.	200/61.62
*	C	US-7,057,124	06-2006	Ieda et al.	200/61.62
*	D	US-6,648,493	11-2003	Klein, Helmut	362/501
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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